

## General features

Type	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
STB85NS04Z	Clamped	< 0.015Ω	80A <sup>(1)</sup>
STB85NS04Z-1	Clamped	< 0.015Ω	80A <sup>(1)</sup>

- 1. Current limited by wire bonding
- 100% avalanche tested
- Low capacitance and gate charge
- 175°C maximum junction temperature

## Description

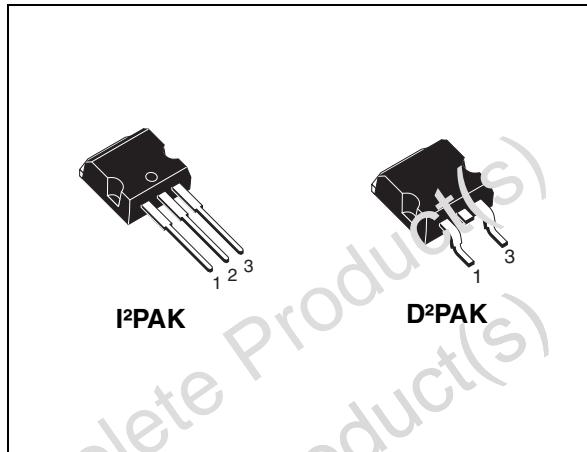
This fully clamped Power MOSFET is produced by using the latest advanced Company's Mesh Overlay™ process which is based on a novel strip layout. The inherent benefits of the new technology coupled with the extra clamping capabilities make this product particularly suitable for the harshest operation conditions such as those encountered in the automotive environment. Any other application requiring extra ruggedness is also recommended.

## Applications

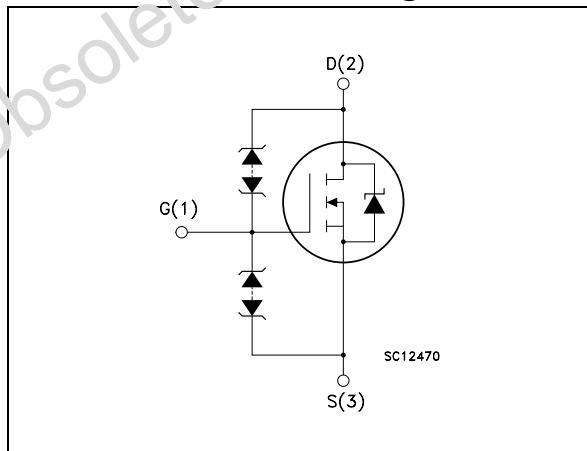
- Switching application
  - Automotive

## Order codes

Part number	Marking	Package	Packaging
STB85NS04ZT4	B85NS04Z	D <sup>2</sup> PAK	Tape & reel
STB85NS04Z-1	B85NS04Z-1	I <sup>2</sup> PAK	Tube



## Internal schematic diagram



## Contents

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# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{GS}=0$ )	33 <sup>(1)</sup>	V
$V_{GS}$	Gate-source voltage	$\pm 18$	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	80 <sup>(2)</sup>	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	60	A
$I_{DG}$	Drain gate current (continuous)	$\pm 50$	mA
$I_{GS}$	Gate source current (continuous)	$\pm 50$	mA
$I_{DM}^{(3)}$	Drain current (pulsed)	320	A
	Derating factor	1.43	W/ $^\circ\text{C}$
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	215	W
$V_{ESD(G-S)}$	Gate-source ESD (HBM-C=100pF, R=1.5k $\Omega$ )	2	kV
$V_{ESD(G-D)}$	Gate-drain ESD (HBM-C=100pF, R=1.5k $\Omega$ )	4	kV
$V_{ESD(D-S)}$	Drain-source ESD (HBM-C=100pF, R=1.5k $\Omega$ )	4	kV
$T_j$	Operating junction temperature	-55 to 175	$^\circ\text{C}$
$T_{stg}$	Storage temperature		

1. Voltage is limited by zener diodes
2. Current limited by wire bonding
3. Pulse width limited by safe operating area

**Table 2. Thermal data**

Symbol	Parameter	Value		Unit
		D <sup>2</sup> PAK	I <sup>2</sup> PAK	
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.7	--	$^\circ\text{C/W}$
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-pcb max	35	--	$^\circ\text{C/W}$
R <sub>thj-amb</sub>	Thermal resistance junction-amb max	62.5	--	$^\circ\text{C/W}$
$T_I$	Maximum lead temperature for soldering purpose	300	--	$^\circ\text{C}$

1. When mounted on 1inch<sup>2</sup> FR-4 board, 2 oz Cu

**Table 3. Avalanche characteristics**

Symbol	Parameter	Max value	Unit
$I_{AS}$	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)	60	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j=25^\circ C$ , $I_D=I_{AS}$ , $V_{DD}=30V$ )	550	mJ

## 2 Electrical characteristics

( $T_{CASE}=25^{\circ}\text{C}$  unless otherwise specified)

**Table 4. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 1\text{mA}$ , $V_{GS} = 0$	33			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 16\text{V}$ , $V_{DS} = 16\text{V}$ , $T_c=125^{\circ}\text{C}$			10 100	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 10\text{V}$			10	$\mu\text{A}$
$V_{GSS}$	Gate-source breakdown voltage	$I_{GS} = 100\mu\text{A}$	13		25	V
$R_G$	Series gate resistance			14		$\Omega$
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 1\text{mA}$	2	3	4	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10\text{V}$ , $I_D = 30\text{A}$		11	15	$\text{m}\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$g_{fs}$	Forward transconductance	$V_{DS} = 25\text{V}$ , $I_D = 30\text{A}$		50		S
$C_{iss}$	Input capacitance					pF
$C_{oss}$	Output capacitance			2500		pF
$C_{rss}$	Reverse transfer capacitance	$V_{DS} = 25\text{V}$ , $f=1\text{MHz}$ , $V_{GS}=0$		800		pF
$C_{rss}$				150		pF
$Q_g$	Total gate charge	$V_{DD}=16\text{V}$ , $I_D = 60\text{A}$		68		nC
$Q_{gs}$	Gate-source charge	$V_{GS} = 10\text{V}$		15		nC
$Q_{gd}$	Gate-drain charge	(see Figure 14)		19		nC

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{r(V_{off})}$	Off-voltage rise time	$V_{clamp}=30V$ , $I_D=60A$		85		ns
$t_f$	Fall time	$R_G=4.7\Omega$ , $V_{GS}=10V$		145		ns
$t_c$	Cross-over time	(see Figure 15)		90		ns

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min	Typ.	Max	Unit
$I_{SD}$	Source-drain current				80	A
$I_{SDM}$	Source-drain current (pulsed)				320	A
$V_{SD}^{(1)}$	Forward on voltage	$I_{SD}=60A$ , $V_{GS}=0$			1.5	V
$t_{rr}$	Reverse recovery time	$I_{SD}=60A$ , $V_{DD}=100V$		65		ns
$Q_{rr}$	Reverse recovery charge	$di/dt=25A/\mu s$ , $T_j=150^\circ C$		0.15		$\mu C$
$I_{RRM}$	Reverse recovery current	(see Figure 18)		4.5		A

1. Pulsed: pulse duration = 300 $\mu s$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

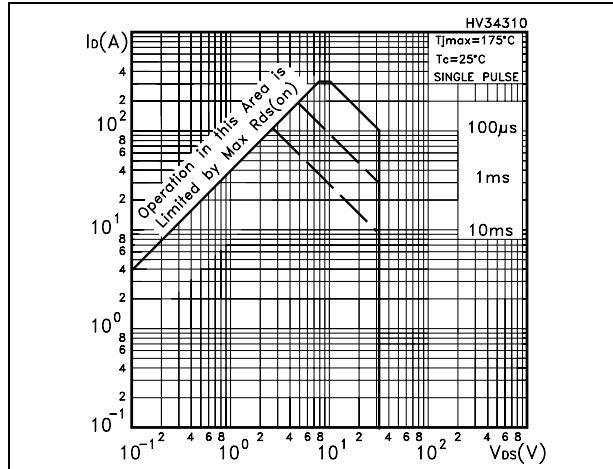


Figure 2. Thermal impedance

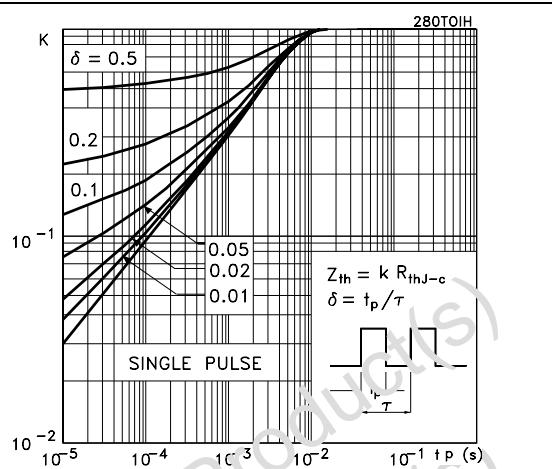


Figure 3. Output characteristics

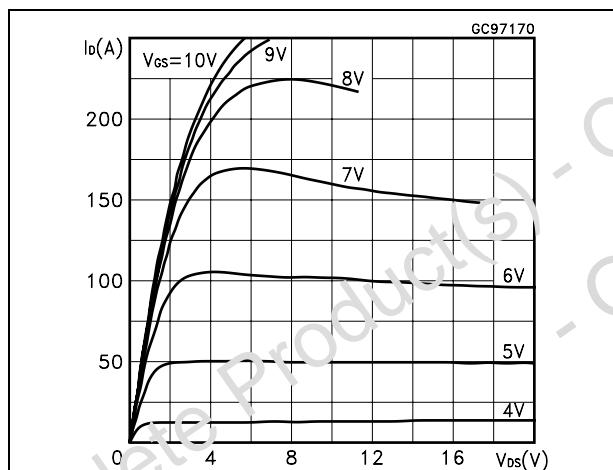


Figure 4. Transfer characteristics

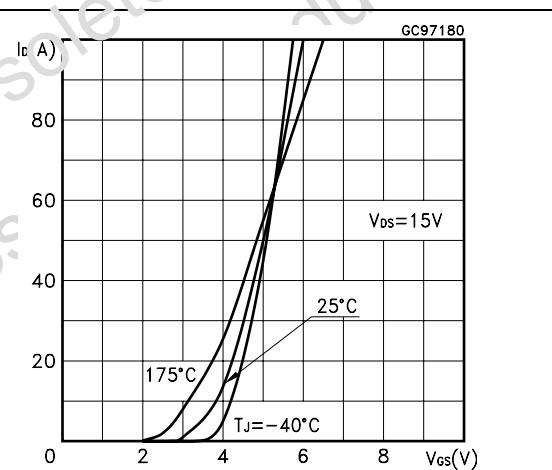


Figure 5. Transconductance

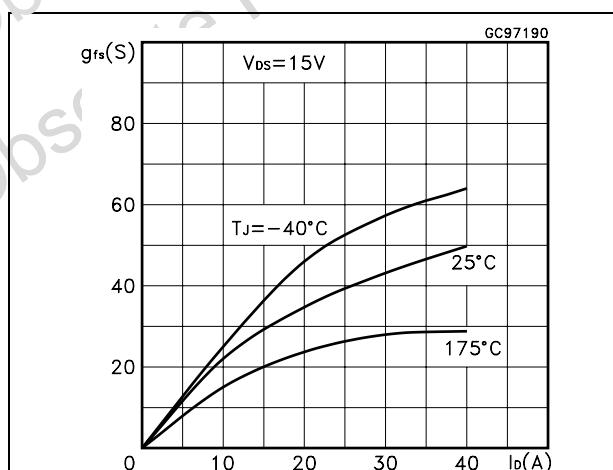
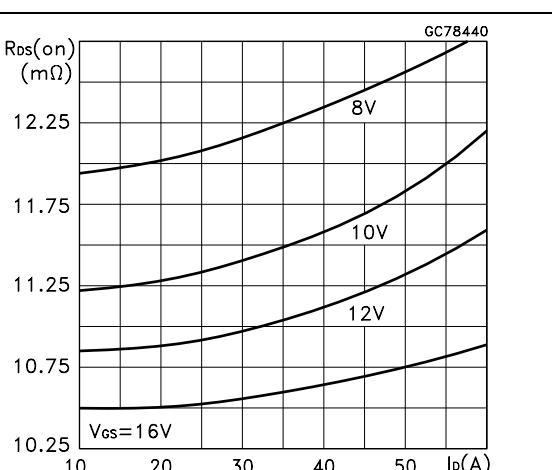
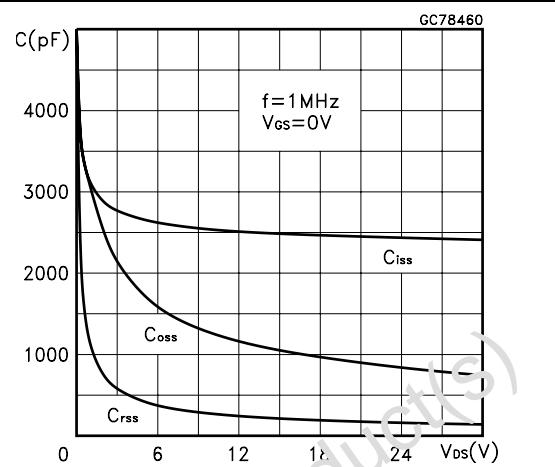
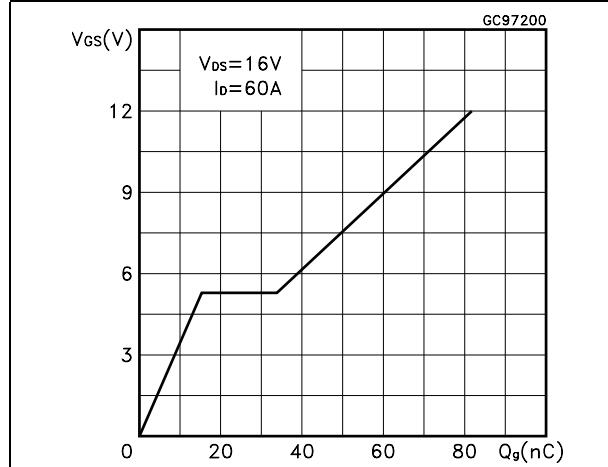
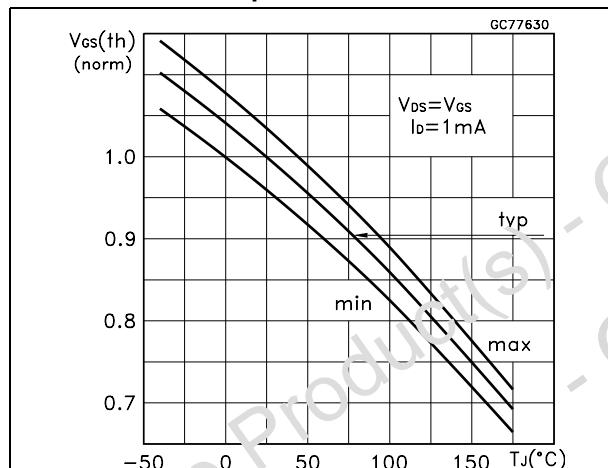
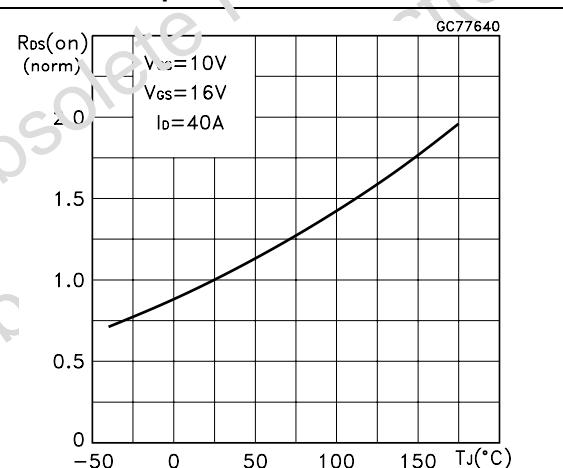
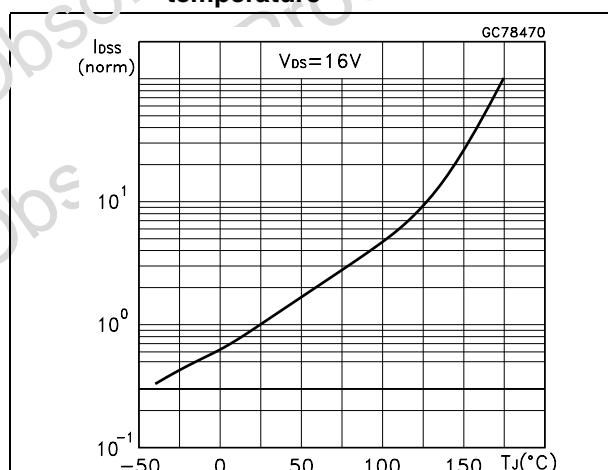
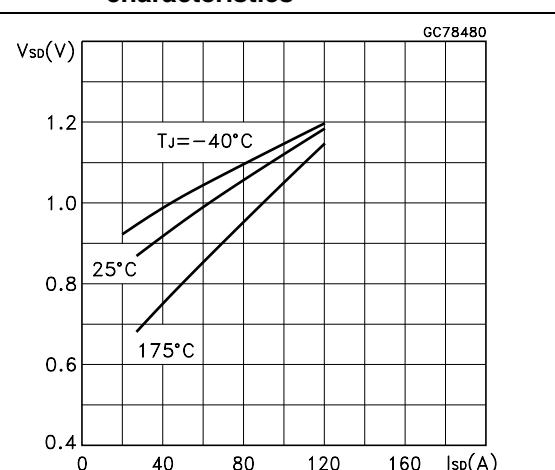


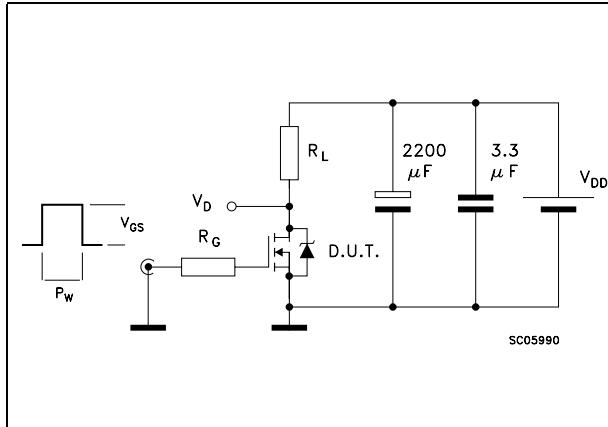
Figure 6. Static drain-source on resistance



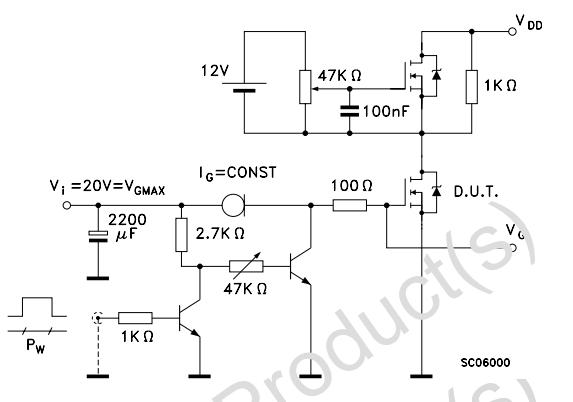
**Figure 7. Gate charge vs gate-source voltage****Figure 9. Normalized gate threshold voltage vs temperature****Figure 10. Normalized on resistance vs temperature****Figure 11. Zero gate voltage drain current vs temperature****Figure 12. Source-drain diode forward characteristics**

### 3 Test circuit

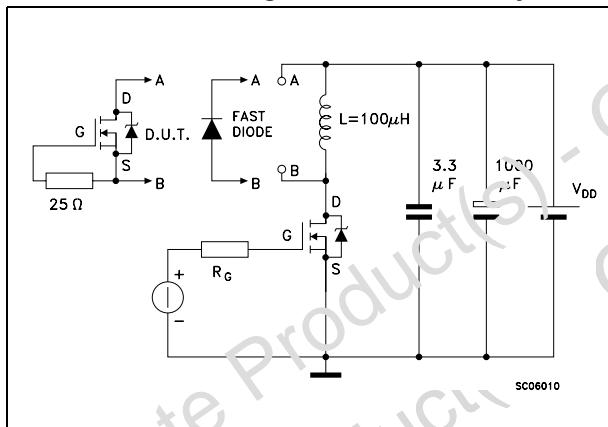
**Figure 13.** Switching times test circuit for resistive load



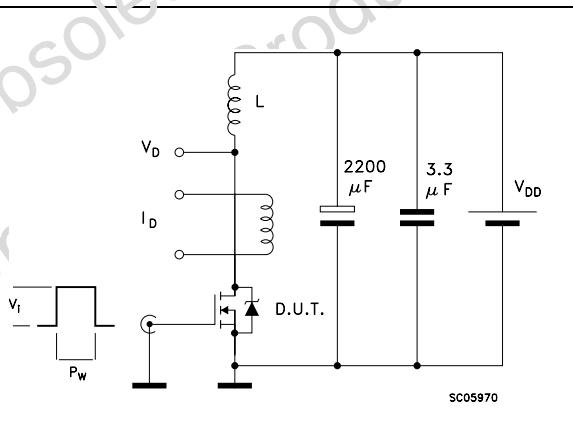
**Figure 14.** Gate charge test circuit



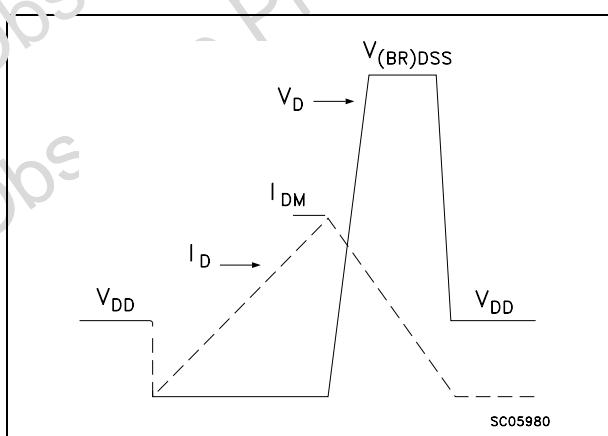
**Figure 15.** Test circuit for inductive load switching and diode recovery times



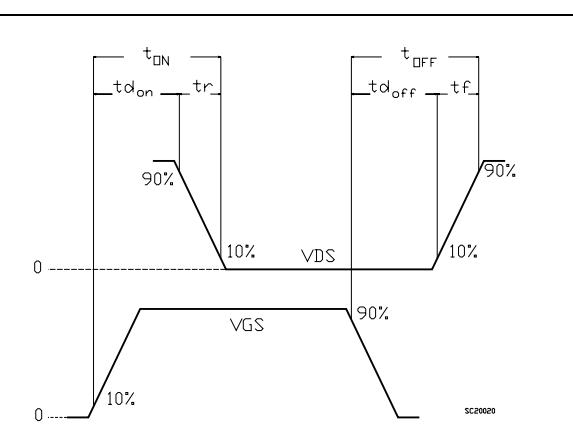
**Figure 16.** Unclamped inductive load test circuit



**Figure 17.** Unclamped inductive waveform



**Figure 18.** Switching time waveform

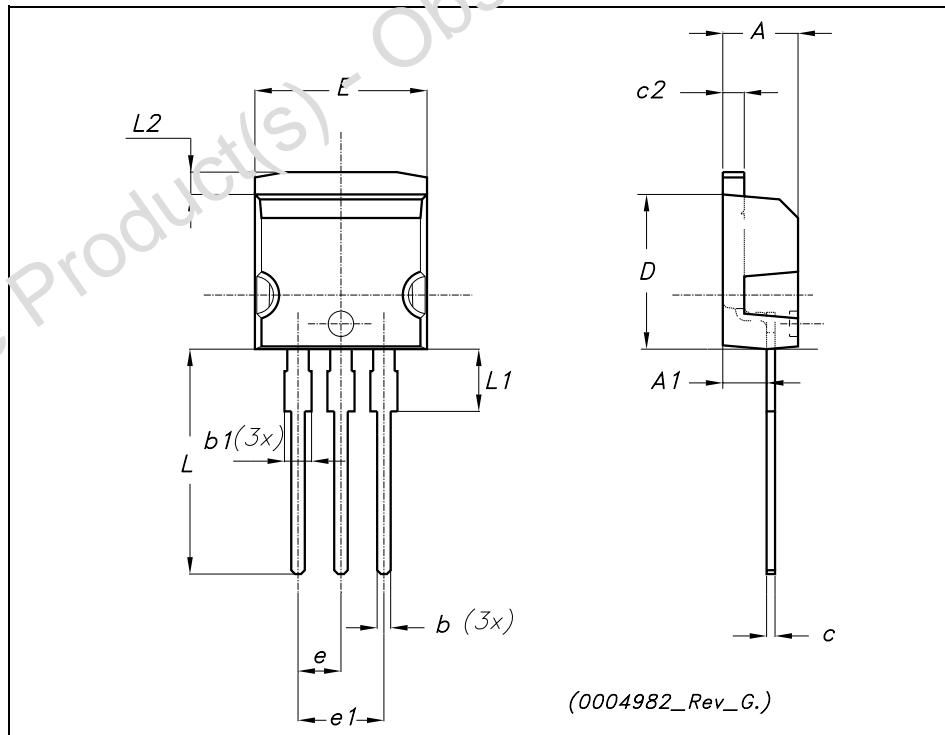


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com)

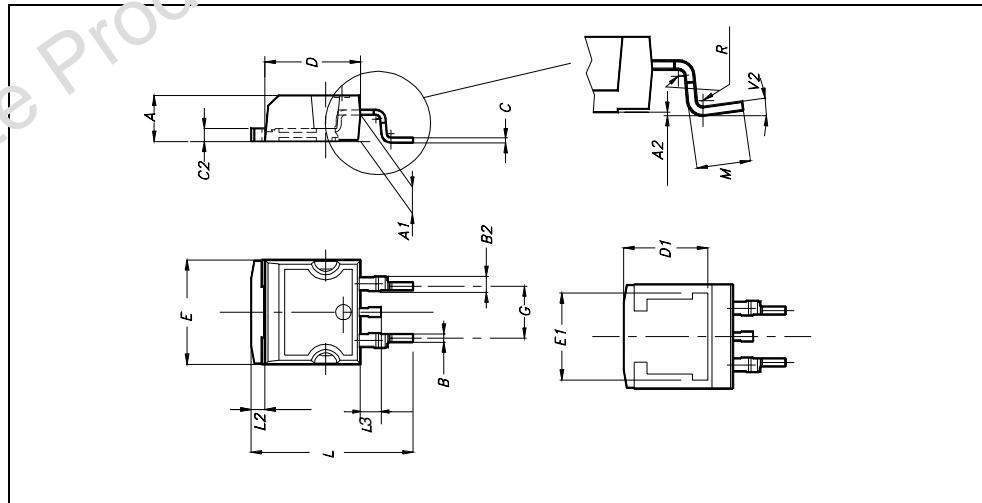
TO-262 (I<sup>2</sup>PAK) MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
A1	2.40		2.72	0.094		0.107
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.49		0.70	0.019		0.027
c2	1.23		1.32	0.048		0.052
D	8.95		9.35	0.352		0.362
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
E	10		10.40	0.393		0.410
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L2	1.27		1.40	0.050		0.055

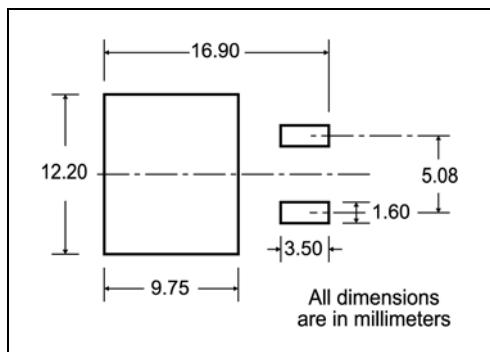


**D<sup>2</sup>PAK MECHANICAL DATA**

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
B	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.07
C	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
M	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	U°		4°			



## 5 Packaging mechanical data

**D<sup>2</sup>PAK FOOTPRINT****TAPE AND REEL SHIPMENT**

**TAPE MECHANICAL DATA**

DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A <sub>0</sub>	10.5	10.7	0.413	0.421
B <sub>0</sub>	15.7	15.9	0.618	0.626
D	1.5	1.6	0.059	0.063
D <sub>1</sub>	1.59	1.61	0.062	0.063
E	1.65	1.85	0.065	0.073
F	11.4	11.6	0.449	0.456
K <sub>0</sub>	4.8	5.0	0.189	0.197
P <sub>0</sub>	3.9	4.1	0.153	0.161
P <sub>1</sub>	11.9	12.1	0.468	0.476
P <sub>2</sub>	1.9	2.1	0.075	0.082
R	50		1.574	
T	0.25	0.35	0.0098	0.0137
W	23.7	24.3	0.933	0.956

\* on sales type

**REEL MECHANICAL DATA**

DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A		330		12.992
B	1.5		0.059	
C	12.8	13.2	0.504	0.520
D	20.2		0.795	
G	24.4	26.4	0.960	1.039
N	100		3.937	
T		30.4		1.197

BASE QTY		BULK QTY	
1000		1000	

## 6 Revision history

**Table 8. Revision history**

Date	Revision	Changes
25-Sep-2006	1	First release

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